

Application No.	Applicant(s)	
10/611,896	LEE ET AL.	
Examiner	Art Unit	
Thien F Tran	2811	

	SEAR	CHED	
Class	Subclass	Date	Examiner
. 257	52, 57	10/27/2004	TT
257	59-61	10/27/2004	TT
257	72	10/27/2004	TT
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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(INCLUDING SEAR	NOTES CH STRATEG	Y)
	DATE	EXMR
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